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APPLICANT(S):

Qing Ma et al.

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**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
RR	A.	US 2001/0055836 A1	12/27/2001	Kunda	1	1	
RR	B.	6,140,144	10/31/2000	Najafi et al.	1	1	
	C.						
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**FOREIGN PATENT DOCUMENTS**

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RR	G.	EP 0 994 330 A1	04/19/2000	EPO	1	1		
	H.							
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	K.							

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	Q.	
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EXAMINER

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10/7/04

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